

**Notice of References Cited**

Application/Control No.

09/773,332

Applicant(s)/Patent Under  
Reexamination  
SWAIN ET AL.

Examiner

Scott Beliveau

Art Unit

2614

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0124262	09-2002	Basso et al.	725/109
	B	US-2003/0149988	08-2003	Ellis et al.	725/87
	C	US-2003/0044165	03-2003	Wood et al.	725/58
	D	US-6,611,654	08-2003	Shteyn, Yevgeniy Eugene	725/86
	E	US-5,805,763	09-1998	Lawler et al.	725/114
	F	US-6,487,663	11-2002	Jaisimha et al.	713/193
	G	US-6,389,467	05-2002	Eyal, Aviv	709/223
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9222983 A2	12-1992	World Intellect	BROWNE et al.	H04H 01/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.